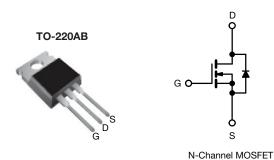


Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.028		
Q _g (Max.) (nC)	67			
Q _{gs} (nC)	18			
Q _{gd} (nC)	25			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- 175 °C operating temperature
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universially preferred for commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRFZ40PbF
Lead (Pb)-free and halogen-free	IRFZ40PbF-BE3

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	60		
Gate-source voltage			V_{GS}	± 20	V	
Continuous drain current	V _{GS} at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	- I _D	50		
		T _C = 100 °C		36	Α	
Pulsed drain current ^a			I _{DM}	200		
Linear derating factor				1.0	W/°C	
Single pulse avalanche energy b			E _{AS}	100	mJ	
Maximum power dissipation	T _C =	25 °C	P_{D}	150	W	
Peak diode recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating junction and storage temperature range			T_J, T_stg	-55 to +175	°C	
Soldering recommendations (peak temperature) d	For 10 s			300	7	
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 44 μ H, R_q = 25 Ω , I_{AS} = 51 A (see fig. 12)
- c. $I_{SD} \le 51$ A, $dI/dt \le 250$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case
- e. Current limited by the package, (die current = 51 A)



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.0		

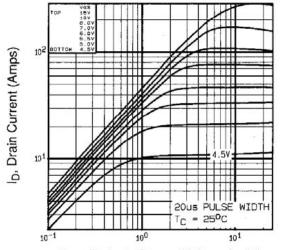
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V _{DS}	V _{GS} :	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.060	-	V/°C
Gate-source threshold voltage	$V_{GS(th)}$	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-source leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero gate voltage drain current	I _{DSS}		V _{DS} = 60 V, V _{GS} = 0 V V _{DS} = 48 V, V _{GS} = 0 V, T _J = 125 °C		-	25 250	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 31 A ^b	-	-	0.028	Ω
Forward transconductance	9 _{fs}	V _{DS}	V _{DS} = 25 V, I _D = 31 A		-	-	S
Dynamic							
Input capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V,		-	1900	-	pF
Output capacitance	C _{oss}			-	920	-	
Reverse transfer capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	170	-	1
Total gate charge	Qg		I _D = 51 A, V _{DS} = 48 V, see fig. 6 and 13 ^b	-	-	67	nC
Gate-source charge	Q _{gs}	V _{GS} = 10 V		-	-	18	
Gate-drain charge	Q_{gd}			=	-	25	
Turn-on delay time	t _{d(on)}			-	14	-	
Rise time	t _r	V_{DD}	$V_{DD} = 30 \text{ V, } I_{D} = 51 \text{ A,}$ $R_{g} = 9.1 \Omega, R_{D} = 0.55 \Omega, \text{ see fig. } 10^{b}$		110	-	ns
Turn-off delay time	t _{d(off)}	$R_g = 9.1 \Omega$,			45	-	
Fall time	t _f			-	92	-	
Internal drain inductance	L _D	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.5	-	
Internal source inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	cs	-				l	
Continuous source-drain diode current	I _S	MOSFET sym showing the	MOSFET symbol showing the		-	50	- A
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		-	-	200	
Body diode voltage	V_{SD}	T _J = 25 °C, I _S = 51 A, V _{GS} = 0 V ^b		-	-	2.5	V
Body diode reverse recovery time	t _{rr}	T _J = 25 °C, I _F = 51 A, dl/dt = 100 A/μs		-	120	180	ns
Body diode reverse recovery charge	Q _{rr}			-	0.53	0.80	nC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



V_{DS}, Drain-to-Source Voltage (volts)

Fig. 1 - Typical Output Characteristics, T_C = 25 °C

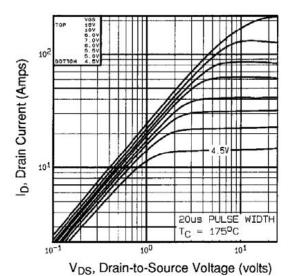
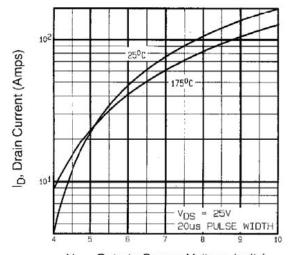


Fig. 2 - Typical Output Characteristics, T_C = 175 °C



V_{GS}, Gate-to-Source Voltage (volts)

Fig. 3 - Typical Transfer Characteristics

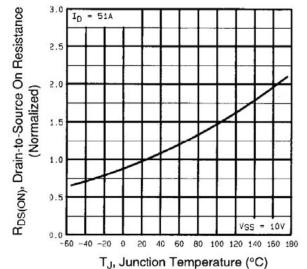


Fig. 4 - Normalized On-Resistance vs. Temperature



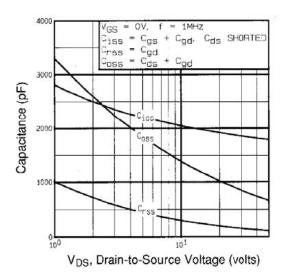


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

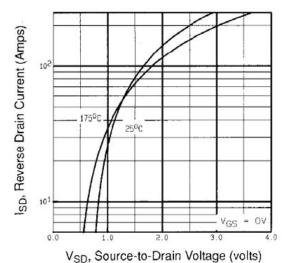


Fig. 7 - Typical Source-Drain Diode Forward Voltage

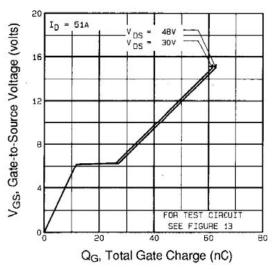


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

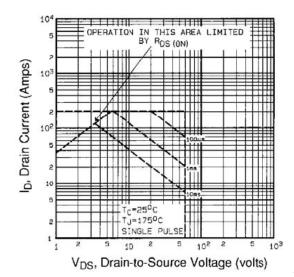


Fig. 8 - Maximum Safe Operating Area



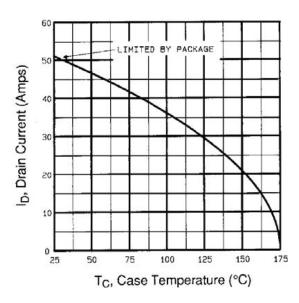


Fig. 9 - Maximum Drain Current vs. Case Temperature

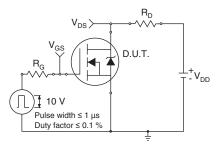


Fig. 10a - Switching Time Test Circuit

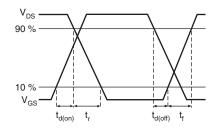


Fig. 10b - Switching Time Waveforms

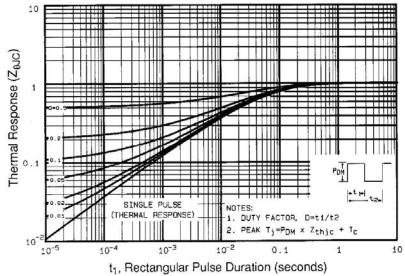


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

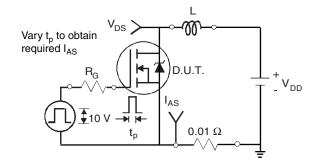


Fig. 12a - Unclamped Inductive Test Circuit

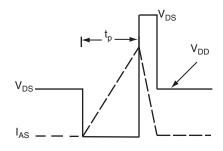


Fig. 12b - Unclamped Inductive Waveforms



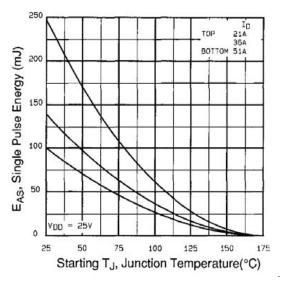


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

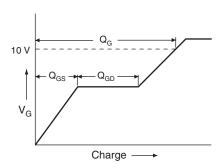


Fig. 13a - Basic Gate Charge Waveform

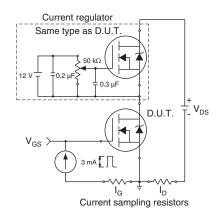
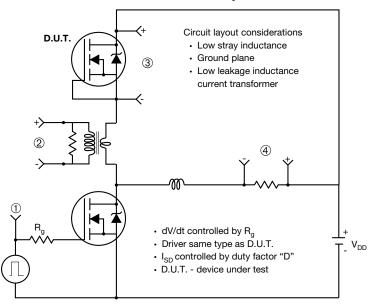


Fig. 13b - Gate Charge Test



Peak Diode Recovery dV/dt Test Circuit



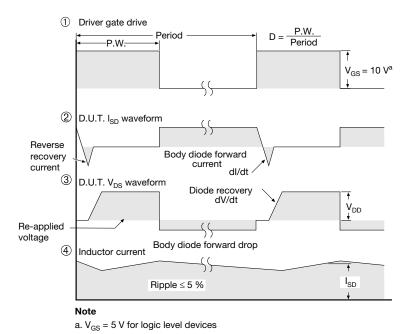


Fig. 14 - For N-Channel

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